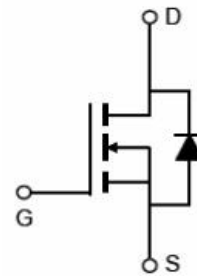


|              |             |
|--------------|-------------|
| $V_{DSS}$    | 85V         |
| $R_{DS(on)}$ | 4.2m (typ.) |
| $I_D$        | 120A        |



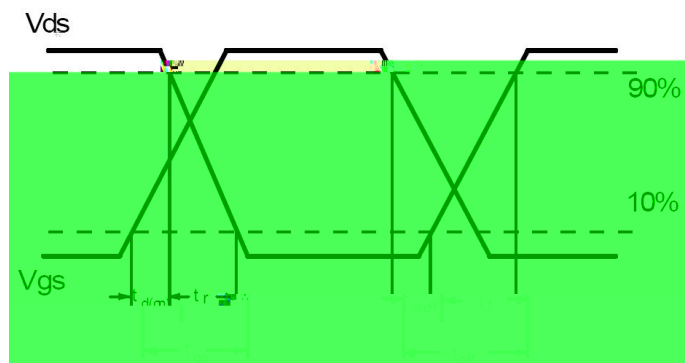
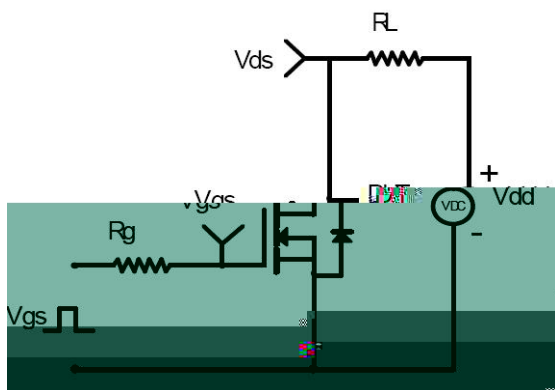
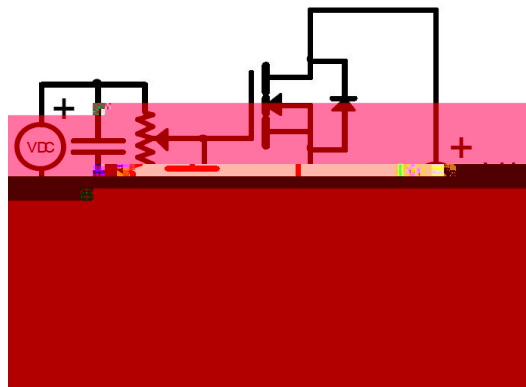
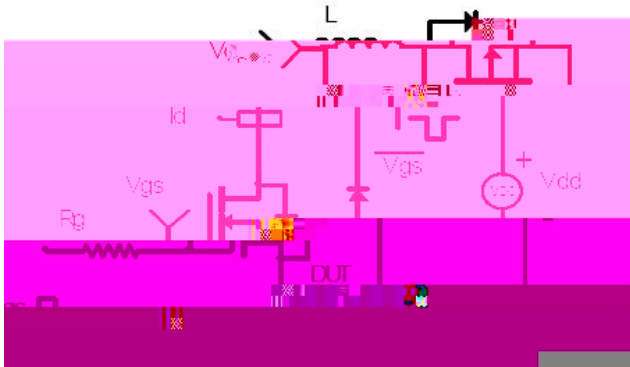
Advanced MOSFET process technology  
 Special designed for PWM, load switching and  
 general purpose applications  
 Ultra low on-resistance with low gate charge  
 Fast switching and reverse body recovery  
 150 operating temperature



It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

|                                |  |             |                  |
|--------------------------------|--|-------------|------------------|
| $I_D @ T_C = 25^\circ\text{C}$ | Continuous Drain Current, $V_{GS} @ 10\text{V}$  | 120         | A                |
| $I_{DM}$                       | Pulsed Drain Current                             | 480         |                  |
| $P_D @ T_C = 25^\circ\text{C}$ | Power Dissipation                                | 220         | W                |
| $V_{DS}$                       | Drain-Source Voltage                             | 85          | V                |
| $V_{GS}$                       | Gate-to-Source Voltage                           | $\pm 20$    | V                |
| $E_{AS}$                       | Single Pulse Avalanche Energy @ $L=0.1\text{mH}$ | 560         | mJ               |
| $T_J \quad T_{STG}$            | Operating Junction and Storage Temperature Range | -55 to +150 | $^\circ\text{C}$ |



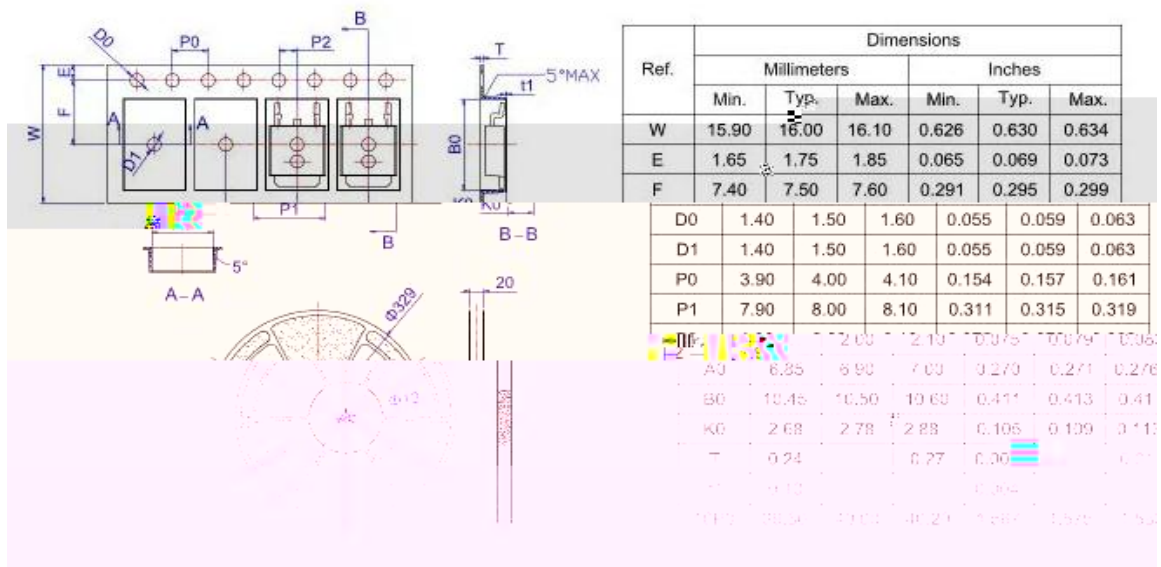
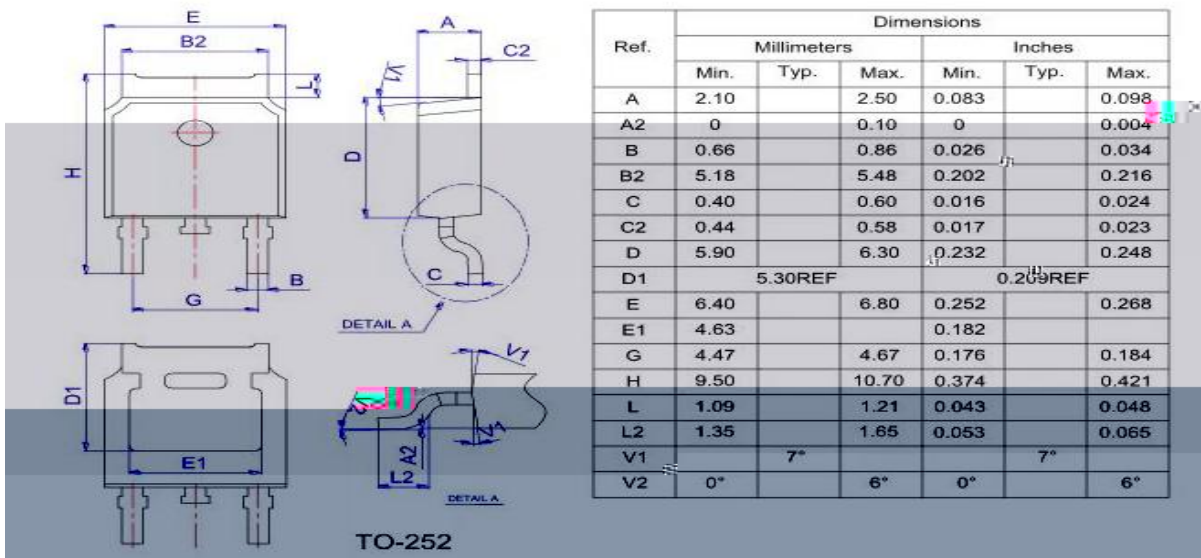


Calculated continuous current based on maximum allowable junction temperature.

Repetitive rating; pulse width limited by max. junction temperature.

The power dissipation  $P_D$  is based on max. junction temperature, using junction-to-case thermal resistance.

The value of  $R_{JA}$  is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25$ .





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